

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/837,222	LIN, WEI
	Examiner	Art Unit
	Tri H. Phan	2616

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner
Interference search history printout		4/18/2006	TP